Application/Control No. Applicant(s)/Patent Under Reexamination 10/529,886 ENDO ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2612 Benjamin C. Lee **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-5,911,773 06-1999 Mutsuga et al. 701/200 Α US-В US-С US-D US-Е US-F US-G US-Н ı US-US-J US-Κ US-L М US-**FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

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